

Features

- 0.22 μm 5-layer epitaxial process
- QML certified
- Radiation hardened FPGAs for space and satellite applications
- Guaranteed total ionizing dose to 100K Rad(si)
- Latch-up immune to LET = 125 MeV cm^2/mg
- SEU immunity achievable with recommended redundancy implementation
- Guaranteed over the full military temperature range (-55°C to $+125^\circ\text{C}$)
- Fast, high-density Field-Programmable Gate Arrays
 - Densities from 100k to 1M system gates
 - System performance up to 200 MHz
 - Hot-swappable for Compact PCI
- Multi-standard SelectIO™ interfaces
 - 16 high-performance interface standards
 - Connects directly to ZBTRAM devices
- Built-in clock-management circuitry
 - Four dedicated delay-locked loops (DLLs) for advanced clock control
 - Four primary low-skew global clock distribution nets, plus 24 secondary global nets
- Hierarchical memory system
 - LUTs configurable as 16-bit RAM, 32-bit RAM, 16-bit dual-ported RAM, or 16-bit Shift Register
 - Configurable synchronous dual-ported 4k-bit RAMs
 - Fast interfaces to external high-performance RAMs
- Flexible architecture that balances speed and density
 - Dedicated carry logic for high-speed arithmetic
 - Dedicated multiplier support
 - Cascade chain for wide-input functions
 - Abundant registers/latches with clock enable, and dual synchronous/asynchronous set and reset
 - Internal 3-state bussing
 - IEEE 1149.1 boundary-scan logic
 - Die-temperature sensing device
- Supported by FPGA Foundation™ and Alliance Development Systems

- Complete support for Unified Libraries, Relationally Placed Macros, and Design Manager
- Wide selection of PC and workstation platforms
- SRAM-based in-system configuration
 - Unlimited reprogrammability
 - Four programming modes
- Available to Standard Microcircuit Drawings. Contact Defense Supply Center Columbus (DSCC) for more information at <http://www.dsccl.dla.mil>
 - 5962-99572 for XQVR300
 - 5962-99573 for XQVR600
 - 5962-99574 for XQVR1000

Description

The QPro™ Virtex™ FPGA family delivers high-performance, high-capacity programmable logic solutions. Dramatic increases in silicon efficiency result from optimizing the new architecture for place-and-route efficiency and exploiting an aggressive 5-layer-metal 0.22 μm CMOS process. These advances make QPro Virtex FPGAs powerful and flexible alternatives to mask-programmed gate arrays. The Virtex radiation hardened family comprises the three members shown in [Table 1](#).

Building on experience gained from previous generations of FPGAs, the Virtex family represents a revolutionary step forward in programmable logic design. Combining a wide variety of programmable system features, a rich hierarchy of fast, flexible interconnect resources, and advanced process technology, the QPro Virtex family delivers a high-speed and high-capacity programmable logic solution that enhances design flexibility while reducing time-to-market.

Refer to the "[Virtex™ 2.5V Field Programmable Gate Arrays](#)" commercial data sheet for more information on device architecture and timing specifications.

Table 1: QPro Virtex Radiation Hardened Field-Programmable Gate Array Family Members.

Device	System Gates	CLB Array	Logic Cells	Maximum Available I/O	Block RAM Bits	Max Select RAM Bits
XQVR300	322,970	32x48	6,912	316	65,536	98,304
XQVR600	661,111	48x72	15,552	316	98,304	221,184
XQVR1000	1,124,022	64x96	27,648	404	131,072	393,216

Radiation Specifications⁽¹⁾

Symbol	Description	Min	Max	Units
TID	Total Ionizing Dose Method 1019, Dose Rate ~9.0 rad(Si)/sec	100	-	krad(Si)
SEL	Single Event Latch-up Immunity Heavy Ion Saturation Cross Section LET > 125 MeV cm ² /mg	-	0	(cm ² /Device)
SEU _{FH}	Single Event Upset CLB Flip-flop Heavy Ion Saturation Cross Section	-	6.5E – 8	(cm ² /Bit)
SEU _{CH}	Single Event Upset Configuration Latch Heavy Ion Saturation Cross Section	-	8.0E – 8	(cm ² /Bit)
SEU _{CP}	Single Event Upset Configuration Latch Proton (63 MeV) Saturation Cross Section	-	2.2E – 14	(cm ² /Bit)
SEU _{BH}	Single Event Upset BRAM Bit Heavy Ion Saturation Cross Section	-	1.6E – 7	(cm ² /Bit)

Notes:

- For more information, refer to "Radiation Test Results of the Virtex FPGA for Space Based Reconfigurable Computing" and "SEU Mitigation Techniques for Virtex FPGAs in Space Applications" at http://www.xilinx.com/products/hirel_qml.htm.

Virtex Electrical Characteristics

Based on preliminary characterization. Further changes are not expected.

All specifications are representative of worst-case supply voltage and junction temperature conditions. The parameters included are common to popular designs and typical applications. Contact the factory for design considerations requiring more detailed information.

Virtex DC Characteristics

Absolute Maximum Ratings

Symbol	Description	Min/Max	Units
V_{CCINT}	Supply voltage relative to GND	–0.5 to 3.0	V
V_{CCO}	Supply voltage relative to GND	–0.5 to 4.0	V
V_{REF}	Input reference voltage	–0.5 to 3.6	V
$V_{IN}^{(3)}$	Input voltage relative to GND	Using V_{REF}	–0.5 to 3.6
		Internal threshold	–0.5 to 5.5
V_{TS}	Voltage applied to 3-state output	–0.5 to 5.5	V
V_{CC}	Longest supply voltage rise time from 1V to 2.375V	50	ms
T_{STG}	Storage temperature (ambient)	–65 to +150	°C
T_J	Junction temperature	+150	°C

Notes:

- Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those listed under Operating Conditions is not implied. Exposure to Absolute Maximum Ratings conditions for extended periods of time may affect device reliability.
- Power supplies may turn on in any order.
- For protracted periods (e.g., longer than a day), V_{IN} should not exceed V_{CCO} by more than 3.6V.

Recommended Operating Conditions

Symbol	Description	Device	Min	Max	Units
V_{CCINT}	Supply voltage relative to GND		2.5 – 5%	2.5 + 5%	V
V_{CCO}	Supply voltage relative to GND		1.2	3.6	V
T_{IN}	Input signal transition time		-	250	ns
T_{IC}	Initialization temperature range ⁽⁴⁾	XQVR300	–55	+125	°C
		XQVR600	–55	+125	°C
		XQVR1000	–40	+125	°C
T_{OC}	Operational temperature range ⁽⁵⁾	XQVR300	–55	+125	°C
		XQVR600	–55	+125	°C
		XQVR1000	–55	+125	°C
ICC_{INTQ}	Quiescent V_{CCINT} supply current	XQVR300	-	150	mA
		XQVR600	-	200	mA
		XQVR1000	-	200	mA
ICC_{CCOQ}	Quiescent V_{CCO} supply current	XQVR300	-	4.0	mA
		XQVR600	-	4.0	mA
		XQVR1000	-	4.0	mA

Notes:

- Correct operation is guaranteed with a minimum V_{CCINT} of 2.25V (Nominal V_{CCINT} – 10%). Below the minimum value stated above, all delay parameters increase by 3% for each 50 mV reduction in V_{CCINT} below the specified range.
- At junction temperatures above those listed as Operating Conditions, all delay parameters increase by 0.35% per °C.
- Input and output measurement threshold is ~50% of V_{CC} .
- Initialization occurs from the moment of V_{CC} ramp-up to the rising transition of the INIT pin.
- The device is operational after the INIT pin has transitioned high.

QPro Virtex Pinouts

Device/Package Combinations and Maximum I/O

Package	Maximum User I/O (excluding dedicated clock pins)		
	XQVR300	XQVR600	XQVR1000
CB228	162	162	-
CG560	-	-	404

Pinout Tables

See the Xilinx WebLINX web site (<http://www.xilinx.com/partinfo/databook.htm>) for updates or additional pinout information. For convenience, Table 2 and Table 3 list the locations of special-purpose and power-supply pins. Pins not listed are user I/Os.

Table 2: Virtex Ceramic Column Grid (CG560) Pinout

Pin Name	Device	CG560
GCK0	XQVR1000	AL17
GCK1		AJ17
GCK2		D17
GCK3		A17
M0		AJ29
M1		AK30
M2		AN32
CCLK		C4
PROGRAM		AM1
DONE		AJ5
INIT		AH5
BUSY/DOUT		D4
D0/DIN		E4
D1		K3
D2		L4
D3		P3
D4		W4
D5		AB5
D6		AC4
D7		AJ4
WRITE		D6
CS		A2
TDI		D5

Table 2: Virtex Ceramic Column Grid (CG560) Pinout (Continued)

Pin Name	Device	CG560
TDO	XQVR1000	E6
TMS		B33
TCK		E29
DXN		AK29
DXP		AJ28
V _{CCINT} (V _{CCINT} pins are listed incrementally. Connect all pins listed for both the required device and all smaller devices listed in the same package.)		A21, B12, B14, B18, B28, C22, C24, E9, E12, F2, H30, J1, K32, M3, N1, N29, N33, U5, U30, Y2, Y31, AB2, AB32, AD2, AD32, AG3, AG31, AJ13, AK8, AK11, AK17, AK20, AL14, AL22, AL27, AN25
V _{CCO} , Bank 0		A22, A26, A30, B19, B32
V _{CCO} , Bank 1		A10, A16, B13, C3, E5
V _{CCO} , Bank 2		B2, D1, H1, M1, R2

Table 2: Virtex Ceramic Column Grid (CG560) Pinout (Continued)

Pin Name	Device	CG560
V _{CCO} , Bank 3	XQVR1000	V1, AA2, AD1, AK1, AL2
V _{CCO} , Bank 4		AM2, AM15, AN4, AN8, AN12
V _{CCO} , Bank 5		AL31, AM21, AN18, AN24, AN30
V _{CCO} , Bank 6		W32, AB33, AF33, AK33, AM32
V _{CCO} , Bank 7		C32, D33, K33, N32, T33
V _{REF} Bank 0 Within each bank, if input reference voltage is not required, all V _{REF} pins are general I/O.		A19, D20, D26, D29, E21, E23, E24, E27,
V _{REF} Bank 1 Within each bank, if input reference voltage is not required, all V _{REF} pins are general I/O.		A6, D7, D10, D11, D13, D16, E7, E15
V _{REF} Bank 2 Within each bank, if input reference voltage is not required, all V _{REF} pins are general I/O.		B3, G5, H4, K5, L5, N5, P4, R1
V _{REF} Bank 3 Within each bank, if input reference voltage is not required, all V _{REF} pins are general I/O.		V4, W5, AA4, AD3, AE5, AF1, AH4, AK2
V _{REF} Bank 4 Within each bank, if input reference voltage is not required, all V _{REF} pins are general I/O.		AK13, AL7, AL9, AL10, AL16, AM4, AM14, AN3
V _{REF} Bank 5 Within each bank, if input reference voltage is not required, all V _{REF} pins are general I/O.		AJ18, AJ25, AK28, AL20, AL24, AL29, AM26, AN23

Table 2: Virtex Ceramic Column Grid (CG560) Pinout (Continued)

Pin Name	Device	CG560
V _{REF} Bank 6 Within each bank, if input reference voltage is not required, all V _{REF} pins are general I/O.	XQVR1000	V29, Y32, AA30, AD31, AE29, AK32, AE31, AH30
V _{REF} Bank 7 Within each bank, if input reference voltage is not required, all V _{REF} pins are general I/O.		D31, E31, G31, H32, K31, P31, T31, L33
GND		A1, A7, A12, A14, A18, A20, A24, A29, A32, A33, B1, B6, B9, B15, B23, B27, B31, C2, E1, F32, G2, G33, J32, K1, L2, M33, P1, P33, R32, T1, V33, W2, Y1, Y33, AB1, AC32, AD33, AE2, AG1, AG32, AH2, AJ33, AL32, AM3, AM7, AM11, AM19, AM25, AM28, AM33, AN1, AN2, AN5, AN10, AN14, AN16, AN20, AN22, AN27, AN33
No Connect	XQVR1000	C31, AC2, AK4, AL3

Table 3: CQFP Package (CB228)

Function	Pin #	Bank #
GND	1	7
TMS	2	
IO	3	
IO	4	
IO_VREF_7	5	
IO	6	
IO	7	
GND	8	
IO	9	
IO	10	
IO	11	
IO_VREF_7	12	
IO	13	
GND	14	
V _{CCINT}	15	
IO	16	
IO	17	
V _{CCO}	18	
IO	19	
IO	20	
IO_VREF_7	21	
IO	22	
IO	23	
IO	24	
IO	25	
IO_IRDY	26	
GND	27	

Table 3: CQFP Package (CB228) (Continued)

Function	Pin #	Bank #
V _{CCO}	28	6
IO_TRDY	29	
V _{CCINT}	30	
IO	31	
IO	32	
IO	33	
IO_VREF_6	34	
IO	35	
IO	36	
V _{CCO}	37	
IO	38	
IO	39	
IO	40	
V _{CCINT}	41	
GND	42	
IO	43	
IO_VREF_6	44	
IO	45	
IO	46	
IO_VREF_6	47	
GND	48	
IO	49	
IO	50	
IO_VREF_6	51	
IO	52	
IO	53	
IO	54	
M1	55	
GND	56	
M0	57	

Table 3: CQFP Package (CB228) (Continued)

Function	Pin #	Bank #
V _{CCO}	58	5
M2	59	
IO	60	
IO	61	
IO	62	
IO_VREF_5	63	
IO	64	
IO	65	
GND	66	
IO_VREF_5	67	
IO	68	
IO	69	
IO_VREF5	70	
IO	71	
GND	72	
V _{CCINT}	73	
IO	74	
IO	75	
V _{CCO}	76	
IO	77	
IO	78	
IO_VREF_5	79	
IO	80	
IO	81	
IO	82	

Table 3: CQFP Package (CB228) (Continued)

Function	Pin #	Bank #
V _{CCINT}	83	4
GCK1	84	
V _{CCO}	85	
GND	86	
GCKO	87	
IO	88	
IO	89	
IO	90	
IO	91	
IO_VREF_4	92	
IO	93	
IO	94	
V _{CCO}	95	
IO	96	
IO	97	
IO	98	
V _{CCINT}	99	
GND	100	
IO	101	
IO_VREF_4	102	
IO	103	
IO	104	
IO_VREF_4	105	
GND	106	
IO	107	
IO	108	
IO_VREF_4	109	
IO	110	
IO	111	
IO	112	
GND	113	
DONE	114	
V _{CCO}	115	

Table 3: CQFP Package (CB228) (Continued)

Function	Pin #	Bank #
PROGRAM	116	3
IO_INIT	117	
IO_D7	118	
IO	119	
IO_VREF_3	120	
IO	121	
IO	122	
GND	123	
IO_VREF_3	124	
IO	125	
IO	126	
IO_VREF_3	127	
IO_D6	128	
GND	129	
V _{CCINT}	130	
IO_D5	131	
IO	132	
V _{CCO}	133	
IO	134	
IO	135	
IO_VREF_3	136	
IO_D4	137	
IO	138	
IO	139	
V _{CCINT}	140	
IO_TRDY	141	
V _{CCO}	142	

Table 3: CQFP Package (CB228) (Continued)

Function	Pin #	Bank #
GND	143	2
IO_IRDY	144	
IO	145	
IO	146	
IO	147	
IO_D3	148	
IO_VREF_2	149	
IO	150	
IO	151	
V _{CCO}	152	
IO	153	
IO	154	
IO_D2	155	
V _{CCINT}	156	
GND	157	
IO_D1	158	
IO_VREF_2	159	
IO	160	
IO	161	
IO_VREF_2	162	
GND	163	
IO	164	
IO	165	
IO_VREF_2	166	
IO	167	
IO_DIN_D0	168	
IO_DOUT_BUSY	169	
CCLK	170	
V _{CCO}	171	

Table 3: CQFP Package (CB228) (Continued)

Function	Pin #	Bank #
TDO	172	1
GND	173	
TDI	174	
IO_CS	175	
IO_WRITE	176	
IO	177	
IO_VREF_1	178	
IO	179	
GND	180	
IO_VREF_1	181	
IO	182	
IO	183	
IO_VREF_1	184	
IO	185	
GND	186	
V _{CCINT}	187	
IO	188	
IO	189	
IO	190	
V _{CCO}	191	
IO	192	
IO	193	
IO_VREF_1	194	
IO	195	
IO	196	
IO	197	
IO	198	
GCK2	199	
GND	200	
V _{CCO}	201	

Table 3: CQFP Package (CB228) (Continued)

Function	Pin #	Bank #
GCK3	202	0
V _{CCINT}	203	
IO	204	
IO	205	
IO	206	
IO_VREF_0	207	
IO	208	
IO	209	
V _{CCO}	210	
IO	211	
IO	212	
IO	213	
V _{CCINT}	214	
GND	215	
IO	216	
IO_VREF_0	217	
IO	218	
IO	219	
IO_VREF_0	220	
GND	221	
IO	222	
IO	223	
IO_VREF_0	224	
IO	225	
IO	226	
TCK	227	
V _{CCO}	228	

Table 3: CQFP Package (CB228) (Continued)

Function	Pin #	Bank #
GND	1, 8, 14, 27, 42, 48, 56, 66, 72, 86, 100, 106, 113, 123, 129, 143, 157, 163, 173, 180, 186, 200, 215, 221	-
V _{CCINT}	15, 30, 41, 73, 83, 99, 130, 140, 156, 187, 203, 214	-
V _{CCO}	18, 28, 37, 58, 76, 85, 95, 115, 133, 142, 152, 171, 191, 201, 210, 228	-

Pinout Diagrams

The following diagrams illustrate the locations of special-purpose pins on Virtex FPGAs. Table 4 lists the symbols used in these diagrams. The diagrams also show I/O-bank boundaries.

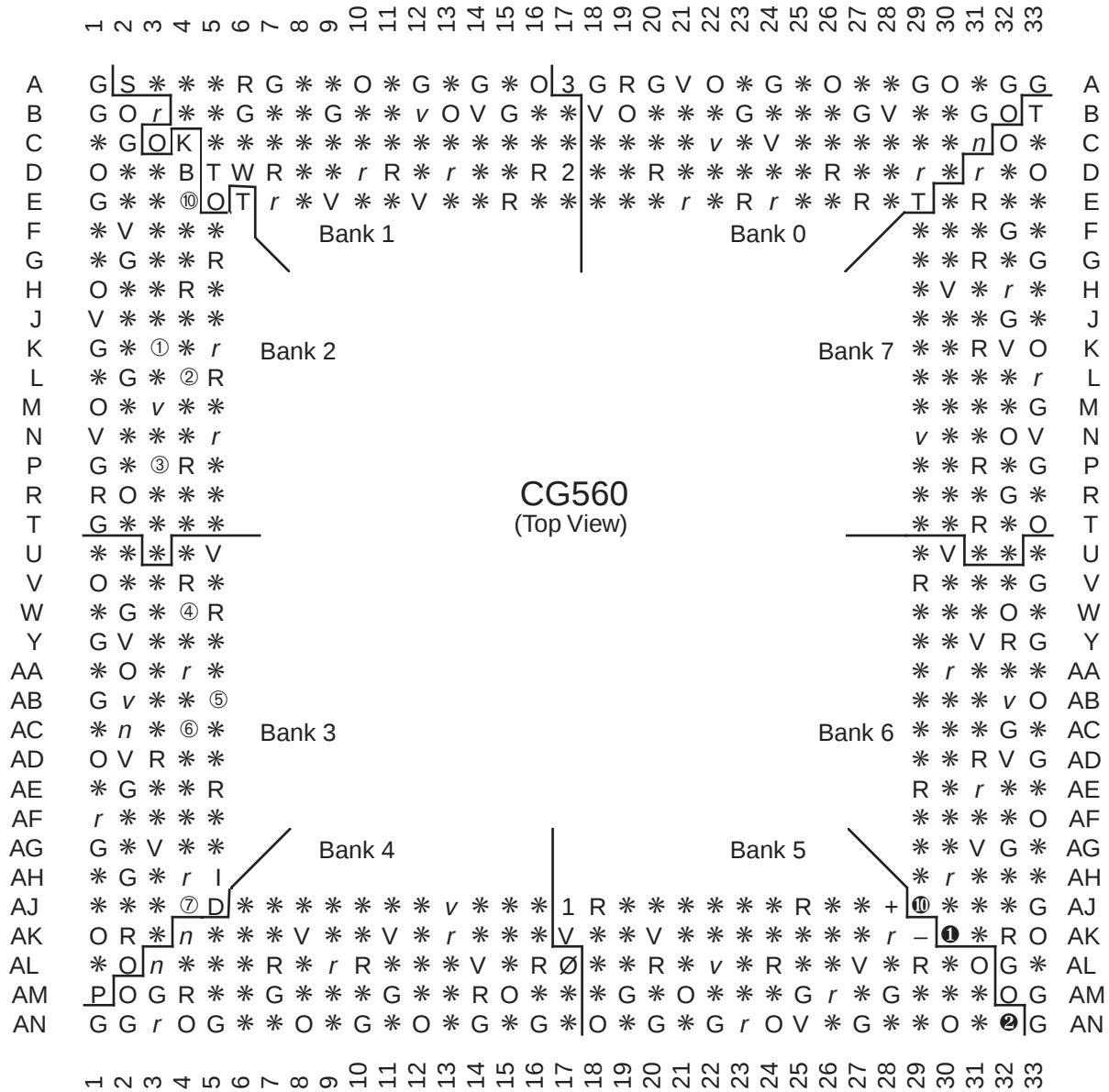
Table 4: Pinout Diagram Symbols

Symbol	Pin Function
S	General I/O
d	Device-dependent general I/O, n/c on smaller devices
V	V _{CCINT}

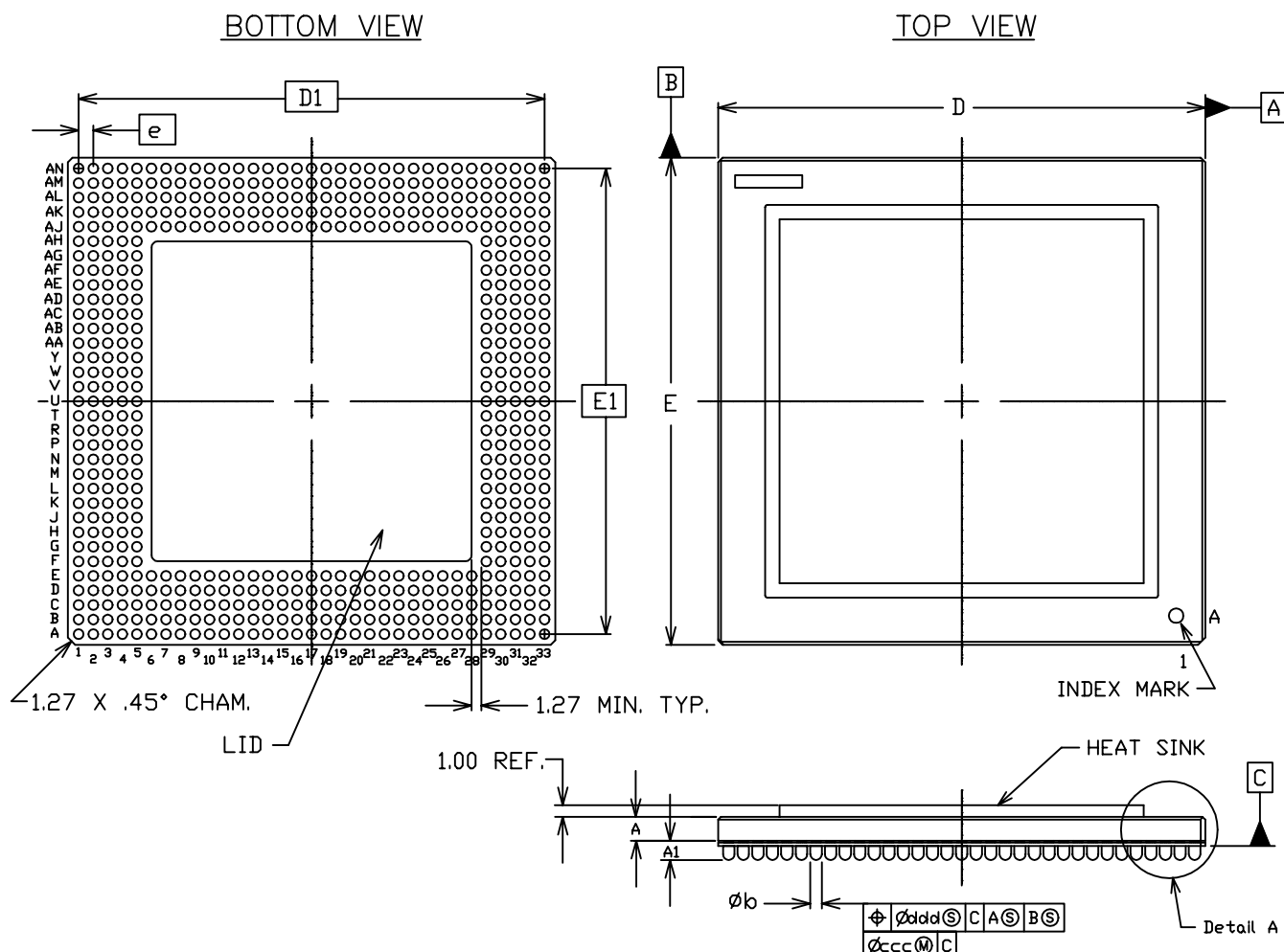
Table 4: Pinout Diagram Symbols (Continued)

Symbol	Pin Function
v	Device-dependent V _{CCINT} , n/c on smaller devices
O	V _{CCO}
R	V _{REF}
r	Device-dependent V _{REF} remains I/O on smaller devices
G	Ground
Ø, 1, 2, 3	Global Clocks
⑩, ①, ②	M0, M1, M2
⑩, ①, ②, ③, ④, ⑤, ⑥, ⑦	D0/DIN, D1, D2, D3, D4, D5, D6, D7
B	DOUT/BUSY
D	DONE
P	PROGRAM
I	INIT
K	CCLK
W	WRITE
S	CS
T	Boundary-scan test access port
+	Temperature diode, anode
–	Temperature diode, cathode
n	No connect

CG560 Pin Function Diagram



Package Drawing CG560 Ceramic Column Grid



NOTES:

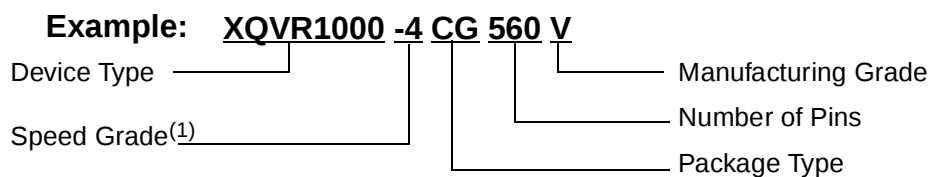
1. ALL DIMENSIONS AND TOLERANCES CONFORM TO ANSI Y14.5M-1994
2. SYMBOL "M" IS THE PIN MATRIX SIZE.
3. LEAD FINISH: HIGH TEMP. SOLDER Pb(90%)/Sn(10%)

DS028_01_011900

Device/Package Combinations and Maximum I/O

Package	Maximum User I/O (excluding dedicated clock pins)		
	XQVR300	XQVR600	XQVR1000
CB228	162	162	-
CG560	-	-	404

Ordering Information



Device Ordering Options

Device Type	Package		Grade		
XQVR300	CB228	228-pin Ceramic Quad Flat Package	M	Military Ceramic	T _C = -55°C to +125°C
XQVR600	CG560	560-column Ceramic Column Grid Package	V	QPro Plus	T _C = -55°C to +125°C
XQVR1000			Q	MIL-PRF-38535 ⁽²⁾	T _C = -55°C to +125°C

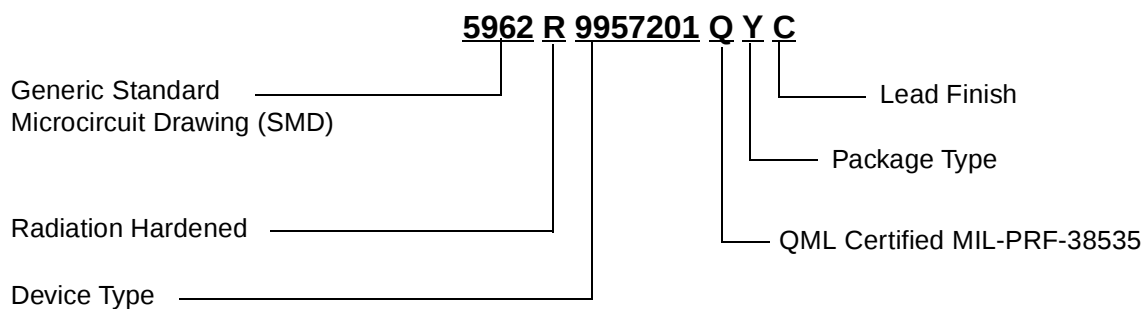
Notes:

- 4 only supported speed grade.
- Class Q must be ordered with SMD number.

Device Ordering Combinations

M Grade	V Grade
XQVR300-4CB228M	XQVR300-4CB228V
XQVR600-4CB228M	XQVR600-4CB228V
XQVR1000-4CG560M	XQVR1000-4CG560V

SMD (Class Q) Odering Options



Valid SMD Combinations

SMD Number	Device	Pkg Markings	Lead Finish
5962R9957201QYC	XQVR300-4CB228Q	Lid	Gold Plate
5962R9957201QZC	XQVR300-4CB228Q	Base	Gold Plate
5962R9957301QYC	XQVR600-4CB228Q	Lid	Gold Plate
5962R9957301QZC	XQVR600-4CB228Q	Base	Gold Plate
5962R9957401QXC	XQVR1000-4CG560Q	-	Solder Column

Revision History

The following table shows the revision history for this document.

Date	Version	Revision
04/25/00	1.0	Initial Xilinx release.
02/13/01	1.1	Updated Temperature Specifications.
11/05/01	1.2	Updated Temp specifications for V600, Added Class V option and SMD. Updated format.